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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/657,269	SHIMOTSUSA ET AL.	
Examiner	Art Unit	
Long Pham	2814	

	SEAR	CHED	
Class	Subclass	Date	Examiner
438	301,232 308	1/25/2006	LP

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
257	301	1/25/2006	LP	

DATE 1/25/2006	EXMR LP
1/25/2006	LP